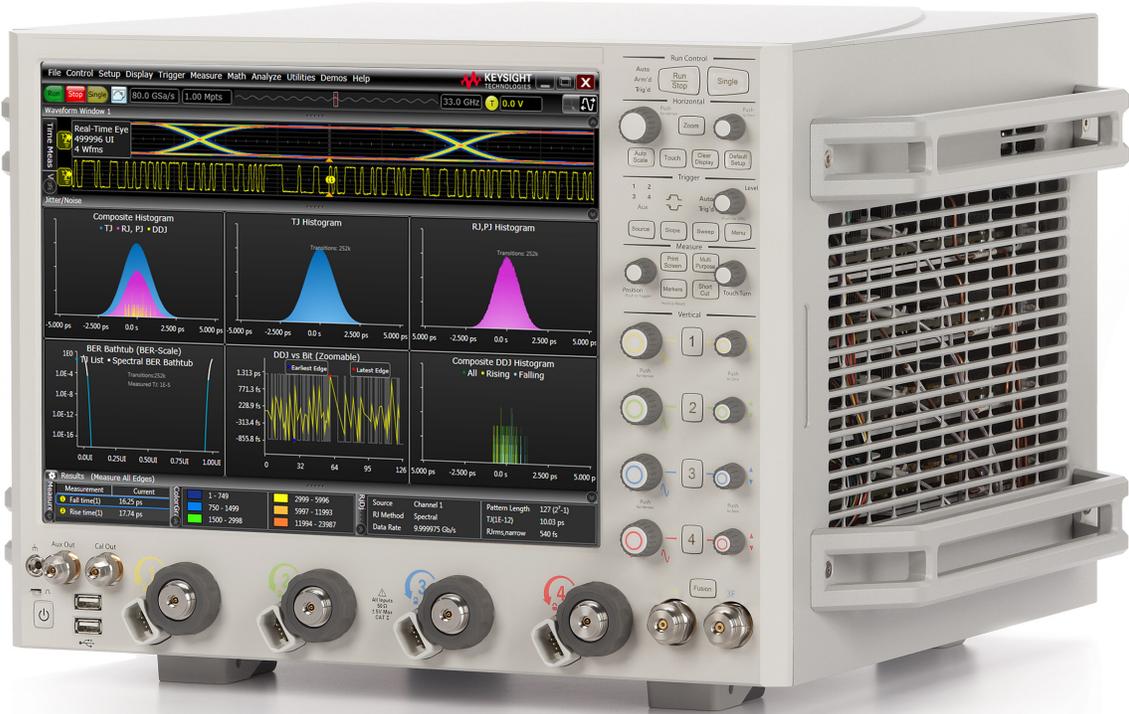


Keysight Technologies EZJIT Complete Jitter and Vertical Noise Analysis Software for Infiniium Oscilloscopes

Data Sheet



Unlocking Measurement Insights

Choosing your Jitter Analysis Software for Infiniium Oscilloscopes

	EZJIT	EZJIT Plus	EZJIT Complete
Model number	E2681A	N5400A	N8823A
Advanced clock recovery	Requires Serial Data Analysis, Model number E2688A	Requires Serial Data Analysis, Model number E2688A	Requires Serial Data Analysis, Model number E2688A
Basic jitter views			
Jitter trend	•	•	•
Jitter histogram	•	•	•
Jitter spectrum	•	•	•
Multi-acquisition	•	•	•
Jitter clock measurements			
Period	•	•	•
Pulse width (+, -, both)	•	•	•
Frequency	•	•	•
Duty cycle (+, -)	•	•	•
Time-interval error	•	•	•
Cycle-cycle jitter	•	•	•
N-cycle jitter	•	•	•
Cycle-cycle +/- width	•	•	•
Cycle-cycle duty cycle	•	•	•
Jitter data measurements			
Time-interval error	•	•	•
Data rate	•	•	•
Unit interval	•	•	•
Delay/edge measurements			
Setup/hold	•	•	•
Phase	•	•	•
Rise/fall time	•	•	•
Jitter separation			
Random jitter (RJ)		•	•
Deterministic jitter (DJ)		•	•
Data dependent jitter (DDJ)		•	•
Inter-symbol interference (ISI)		•	•
Duty cycle distortion (DCD)		•	•
Bounded uncorrelated jitter (BUJ)		•	•
Periodic jitter (PJ)		•	•
Aperiodic bounded uncorrelated jitter (ABUJ)		•	•
Total jitter (TJ) estimation		•	•
BER range		•	•
Max pattern length periodic mode		•	•
Max pattern length arbitrary mode		•	•

Choosing your Jitter Analysis Software for Infiniium Oscilloscopes *(Continued)*

Model number	EZJIT E2681A	EZJIT Plus N5400A	EZJIT Complete N8823A
Advanced jitter views			
Real-time eye	Requires Serial Data Analysis, Model number E2688A	Requires Serial Data Analysis, Model number E2688A	Requires Serial Data Analysis, Model number E2688A
BER bathtub		•	•
DDJ vs bit		•	•
Composite histograms		•	•
TJ histogram		•	•
DDJ histogram		•	•
RJ/PJ histogram		•	•
RJ/PJ spectrum		•	•
Vertical noise analysis			
Vertical noise decomposition			•
Total interference estimation			•
Separate analysis of one and zero levels			•
Advanced noise views			•

EZJIT Complete: Advanced Jitter and Vertical Noise Separation and Analysis

Setting up the oscilloscope for vertical noise analysis

Vertical Noise analysis software algorithms are very similar to the jitter algorithms found in EZJIT Plus. For this reason, and because the engineering tasks are related, the noise and jitter capabilities are merged together in one GUI and combined to constitute EZJIT Complete. It is found in both analysis and measurement tabs in the Infiniium oscilloscope control graphical user interface. Selecting either of these yields the entry dialog which allows manipulation of conditions for measurement, and also presents a setup wizard. The setup wizard is the best and most carefree way to ensure good measurements and is recommended.

Viewing the setup dialog one can see the close relationship jitter and noise measurement have. There is a common section that addresses the channel to be measured, the pattern type, whether it should be automatically evaluated, BER level, number of graphs to present for analysis insight, and graphical controls (such as Log/Linear format and Q vs BER scales. Additionally, there are common settings in clock recovery and thresholds. One cannot be too careful about Clock Recovery and it deserves special note. While the need for clock recovery should be obvious for jitter evaluation because jitter depends on comparison against an underlying time reference, noise evaluation requirement of clock recovery may not be so obvious. It is critical the vertical noise analysis software evaluates a vertical slice in the eye diagram and must have a clock reference to do so.

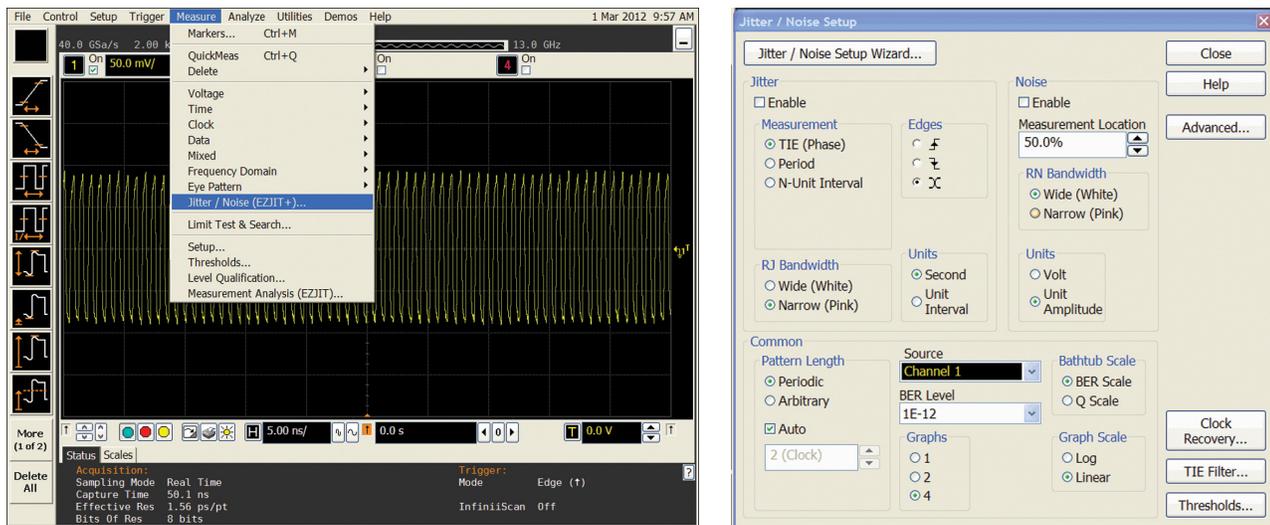


Figure 3. Jitter and Noise Measurement control dialog available from Analyze and Measurement Tabs and resulting setup control dialog.

Use the Setup Wizard!

In all of Infiniium’s measurement software, setup wizards guide users to the quickest way to achieve results and the vertical noise analysis software in EZJIT Complete is no exception. Use the Setup Wizard for bulletproof setup and results.

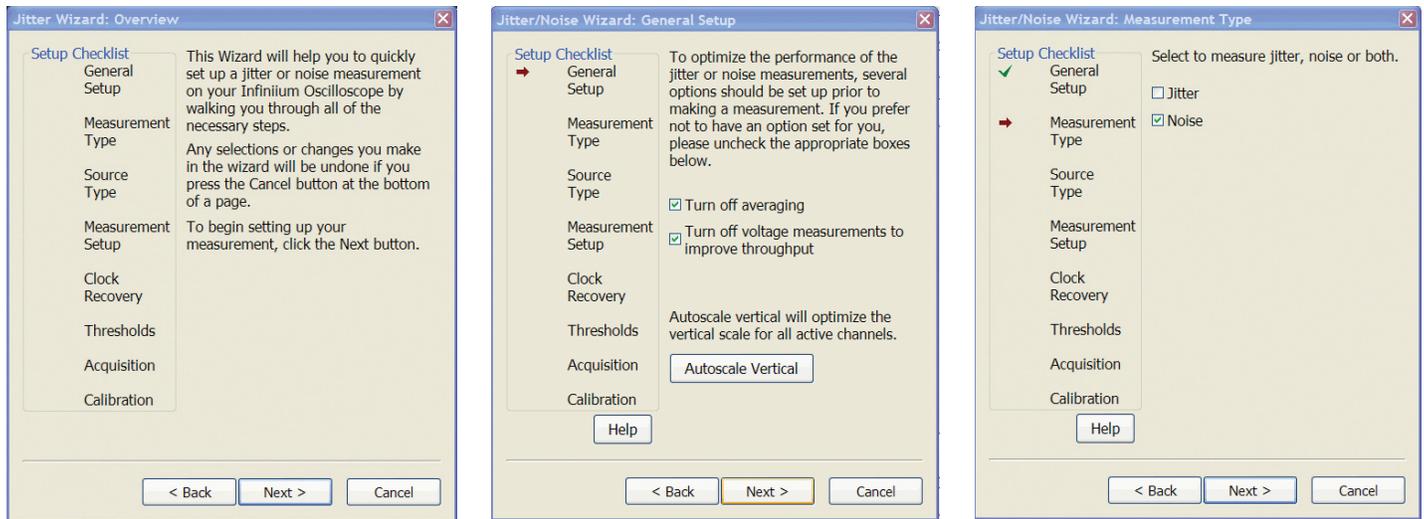


Figure 4. Jitter and Noise Wizard. The setup checklist is presented in the first wizard screen and the user can see where in the process they are every step of the way.

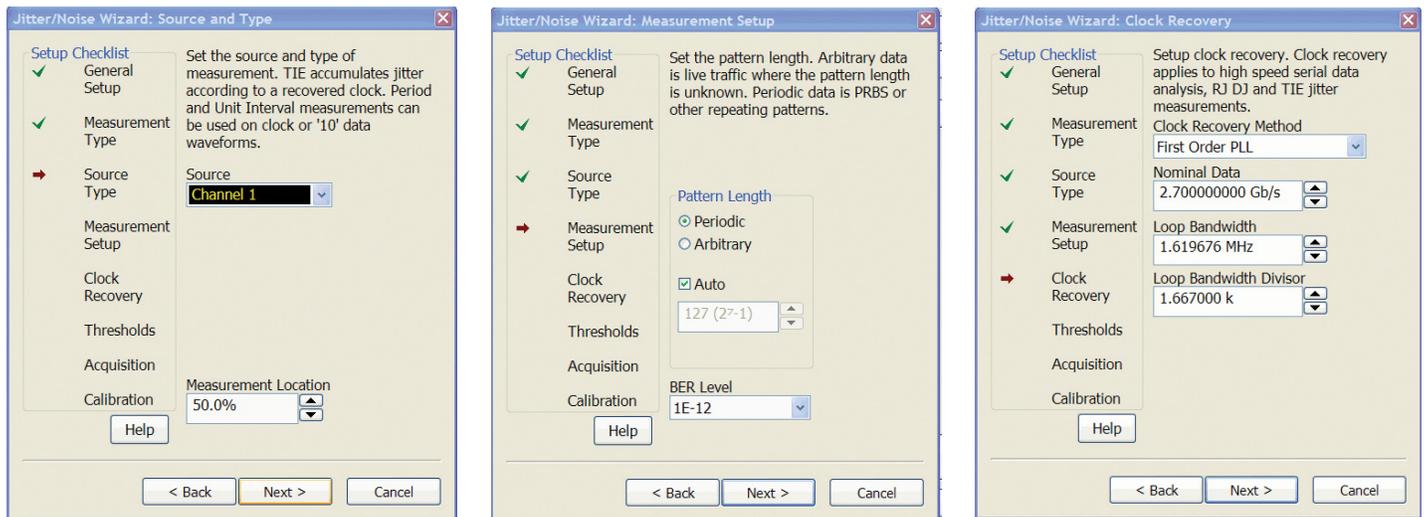


Figure 5. Jitter and Noise Wizard. Key parameters are selected. From the target and location in the unit interval, to whether periodic or arbitrary patterns are being analyzed, to clock recovery.

Use the Setup Wizard! (Continued)

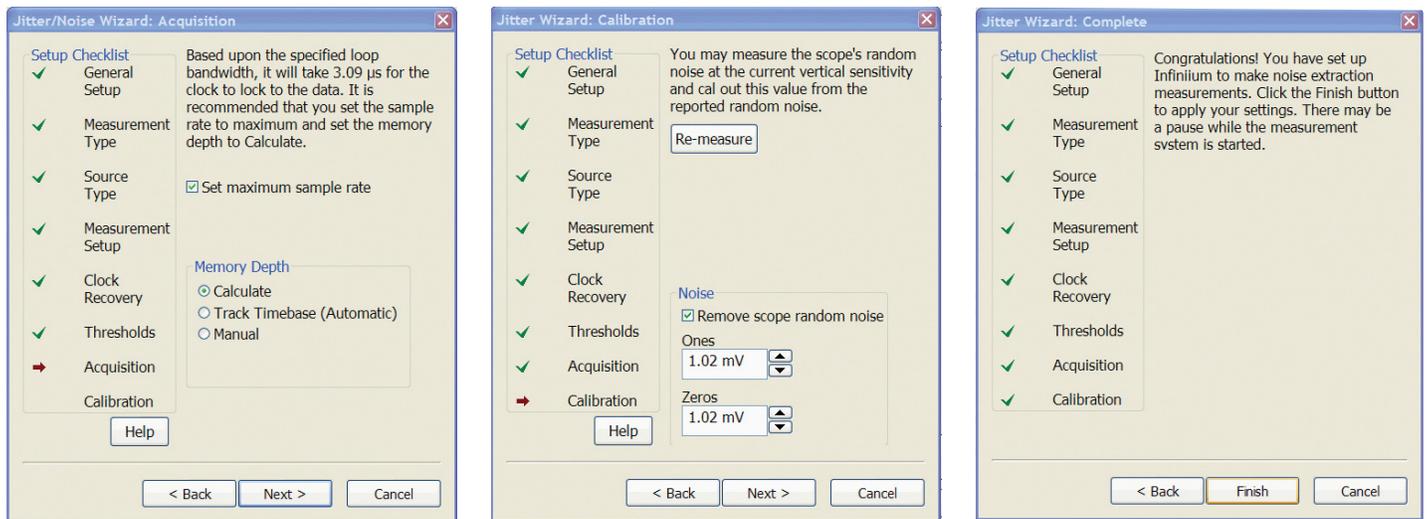


Figure 6. Jitter and Noise Wizard. Selecting 'Calculate' memory depth assures appropriate acquisition depth (memory) for highest accuracy. The Calibration tab will activate scope to measure its own noise and the check box selection of 'Remove scope random noise' will perform a root sum square subtraction of the scope's random noise from all subsequent calculations of random noise.

The jitter wizard guides you through the setup process, from General Setup to the Calibration where the oscilloscope's contribution to noise is subtracted. The default values in the wizard optimize accuracy and robustness of the measurement.

Viewing and analyzing vertical noise

Analysis of your signal is portrayed in graphical and tabular forms. The graphical portrayals provide the most immediate insight while the tabular provide the numeric evaluation you need for evaluating your target.

When analyzing vertical noise, four graphs will be presented as the standard configuration. These are shown below. These are considered to provide the most insight immediately, but the user also has more options available.

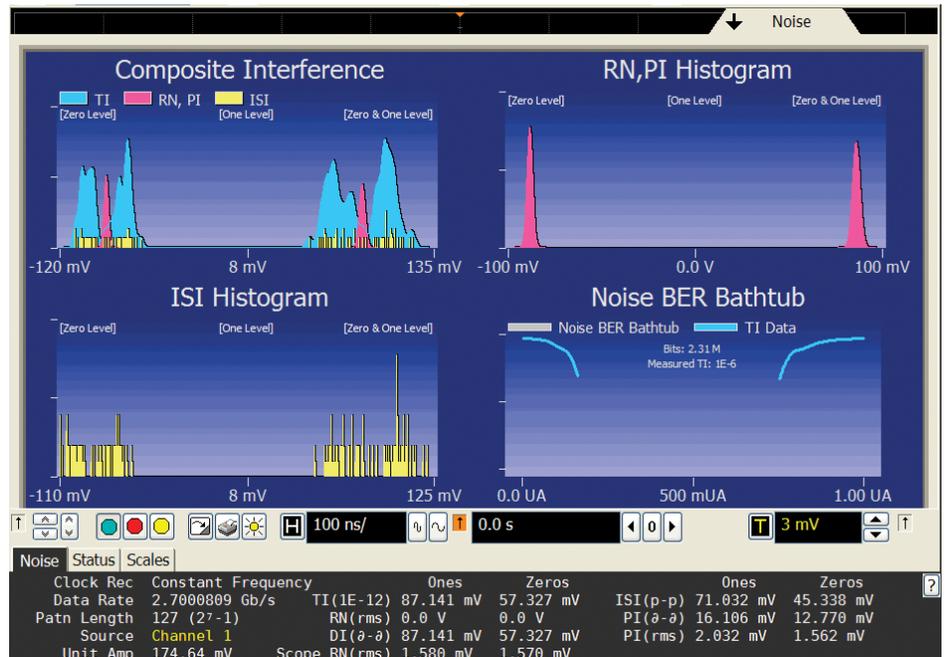


Figure 7. Standard graphical portrayal of vertical noise decomposition. From top to right: composite interference histogram, random and periodic histogram, intersymbol interference histogram, and bathtub plot.

Other Views

In addition to the vertical noise histograms and bathtub plots are other graphical portrayals that can give you the information you need to act. These are noise spectrum, threshold spectrum and ISI vs Bit. The noise spectrum and threshold spectrum will show periodic and random components vs frequency. The advantage of viewing the noise spectrum plot is to understand the noise contribution frequencies. For instance, if there is power supply radiation source or grounding issue on one side of a differential pair it will show up as common and differential noise and will be immediately clear on the plot. The threshold plot (not shown) shows the calculated threshold vs frequency that the vertical noise decomposition software uses to discern between a periodic noise component and random noise.

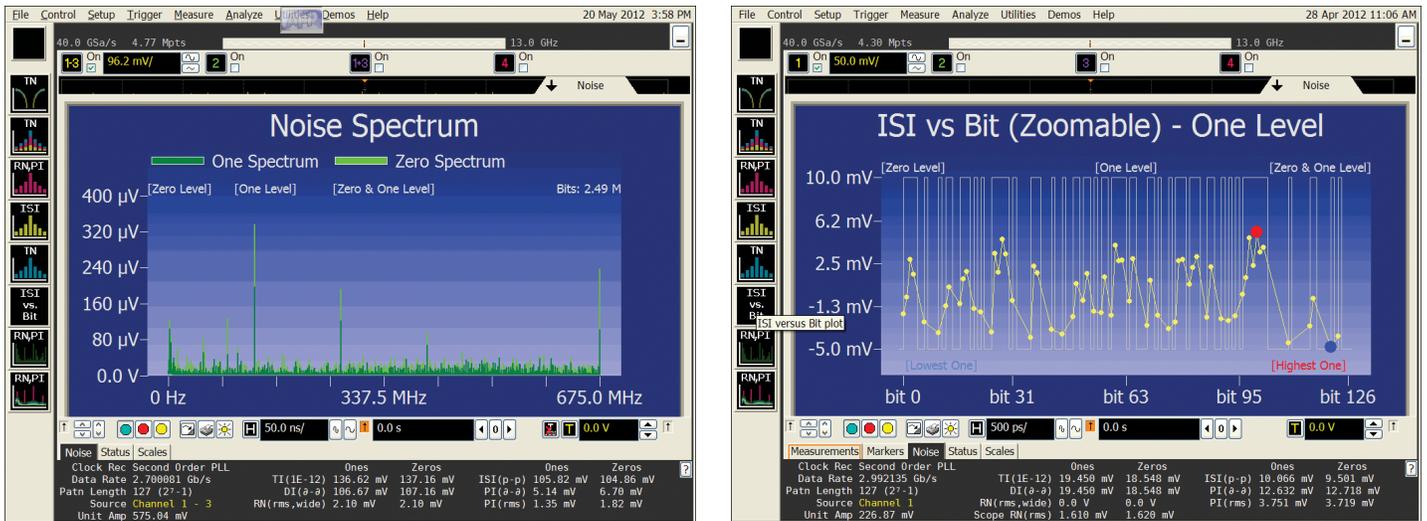


Figure 8. Spectrum portrayal of the vertical noise and pattern dependent noise (ISI) in ISI vs Bit plots. By selecting on the plot labels, the user can select between analyzing zeroes, ones, or both simultaneously.

Analysis of ones, zeroes, or both ones and zeroes

The vertical noise decomposition software will default to the four-graph view seen in Figure 7, however two other choices are available to you. These are two-graph and one-graph formats for better focused viewing. The selection is available in the entry screen shown in Figure 3.

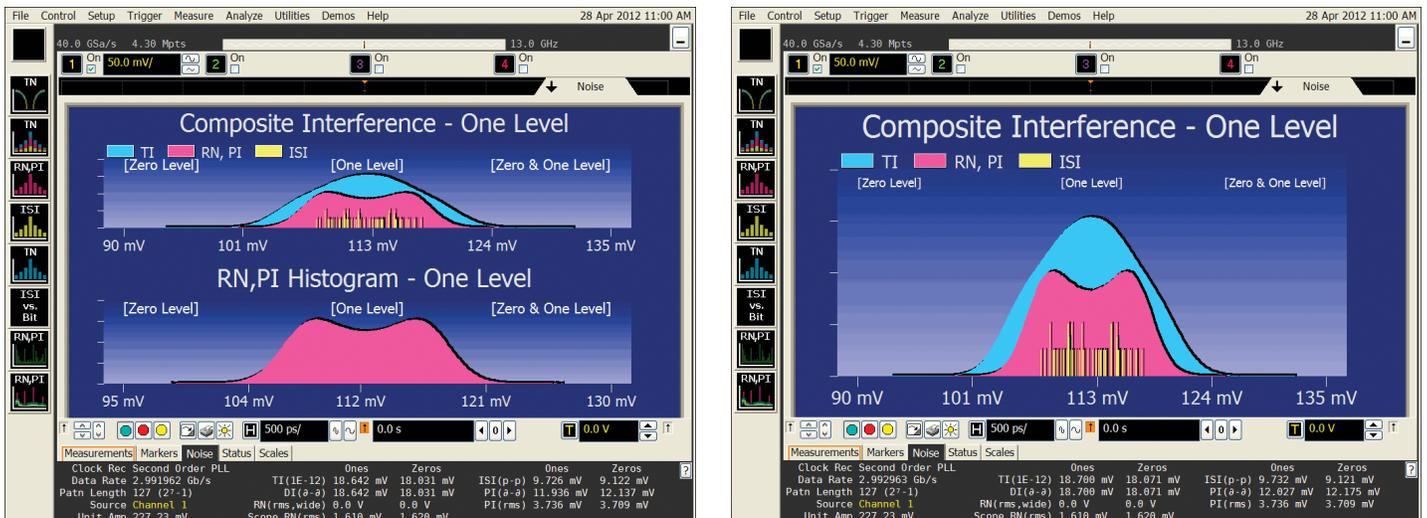


Figure 9. The EZJIT Complete entry screen allows selection of 4, 2 or 1 graph formats.

Other Views (Continued)

Analysis of ones, zeroes, or both ones and zeroes

Close analysis of the four-graph view seen in Figure 7, will reveal that the plot is rendering both One and Zero analysis on each of the graphs shown. In those graphs, if you should want to examine the 'One' histograms or 'Zero' histograms in greater detail, you can click on the '[One Level]' or '[Zero Level]' labels. When you do so, the graph will rescale and show the side selected (One or Zero). This is depicted in Figure 10.

Tabular results

Finally, the measured results are available in tabular form or over remote user interface. The results are available now in their own results tab at the bottom of the infiniium screen under 'Noise'.



Figure 10. Focus on just the Ones, or the Zeroes or both: Analysis for Ones is shown here.

Measurements	Markers	Noise	Status	Scales	Ones	Zeroes	Ones	Zeroes
Clock Rec	Second Order PLL				19.403 mV	19.143 mV	10.087 mV	9.522 mV
Data Rate	2.993028 Gb/s	TI(1E-12)			19.403 mV	19.143 mV	12.760 mV	12.985 mV
Patn Length	127 (2 ⁷ -1)	DI(Δ-Δ)			0.0 V	0.0 V	3.742 mV	3.722 mV
Source	Channel 1	RN(rms,wide)			1.610 mV	1.620 mV		
Unit Amp	226.85 mV	Scope RN(rms)						

Figure 11. New Noise tab displaying all the values associated with vertical decomposition.

Other analyses enabled

Fixed Level Analysis: if your device is fixed at a high or a low, you can still analyze the system noise. In this case, you do not have a signal to perform first or second order recovery from data, so you can use an explicit clock and adjust threshold and hysteresis settings in the wizard.

Sweep the Eye: To comprehend vertical performance throughout the eye, the user can sweep the measurement location in the eye and performing noise analysis at each vertical solutions. With similar measurements of jitter at different horizontal thresholds the results can be processed externally to render a complete contour around the eye opening. This would be done to evaluate the statistical eye contour, or to measure over a specific range given assumptions of the behavior of the system receiver. An example of this is shown in Figure 2.

EZJIT Plus: Advanced Jitter Separation and Analysis

Separate jitter on periodic and arbitrary patterns

Typically, jitter separation is performed on repetitive waveforms that are designed to stress the data transmission link and the receiver's clock recovery circuitry. However, many embedded designs using multi-vendor chipsets are limited to testing live traffic with additional align characters and packet frames that may not be repetitive. EZJIT Plus allows designers to choose between periodic and arbitrary data modes when analyzing jitter for compliance. In the arbitrary data mode, the ISI Filter shows victim-aggressor relationships between each rising and falling edge that are N-edges apart in the captured waveform. By setting the filter wide enough to capture all significant relationships, designers can quickly analyze ISI problems and accurately separate RJ/DJ parameters to provide a TJ estimation at low BER.

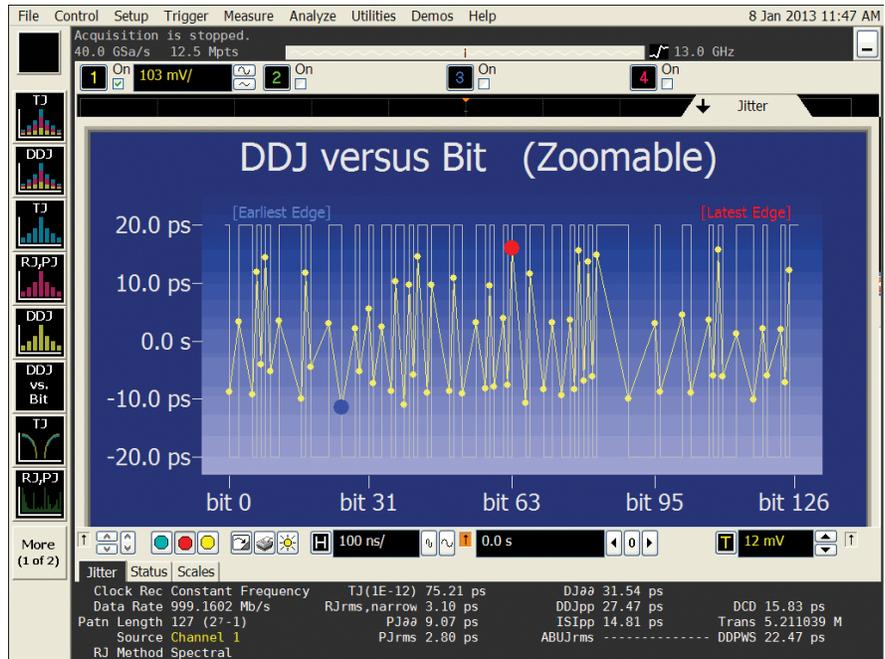


Figure 12. DDJ vs. Bit chart.

Easy-to-use Jitter Separation Wizard

The easy-to-use wizard built into EZJIT Plus makes setting up advanced jitter separation simple. Walk through the measurement setup step-by-step to set critical parameters such as thresholds, vertical scaling, and clock recovery. The result: fast and accurate separation of signal jitter into components and flexible jitter views to provide critical insight.

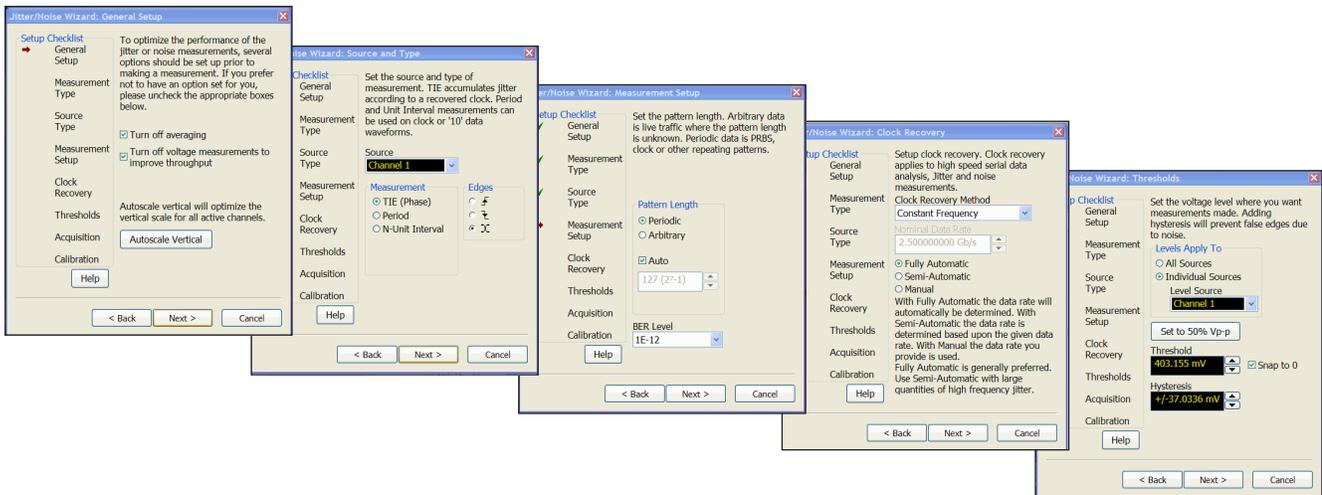


Figure 13. RJ/DJ Wizard allows user selection of data pattern type, TJ BER calculation level, clock recovery type and jitter measurement threshold.

Accurate Random Jitter Separation using Spectral and Tail Fit Algorithms

The problem

Common spectral algorithm for RJ extraction over-reports RJ.

Why?

Any Aperiodic Bounded Uncorrelated Jitter (ABUJ) on the signal is factored into RJ. A common source of ABUJ is crosstalk from adjacent signals.

How does this affect me?

First, the RJ measurement can be inaccurate. Second, when measuring Total Jitter (TJ) vs. BER, TJ can be dramatically overestimated due to the RJ multiplier. For example, $TJ = DJ + 14 * RJ_{RMS}$ for a BER of 10^{-12} . This means the scope will provide an unfairly negative report of the overall jitter performance of your serial data link.

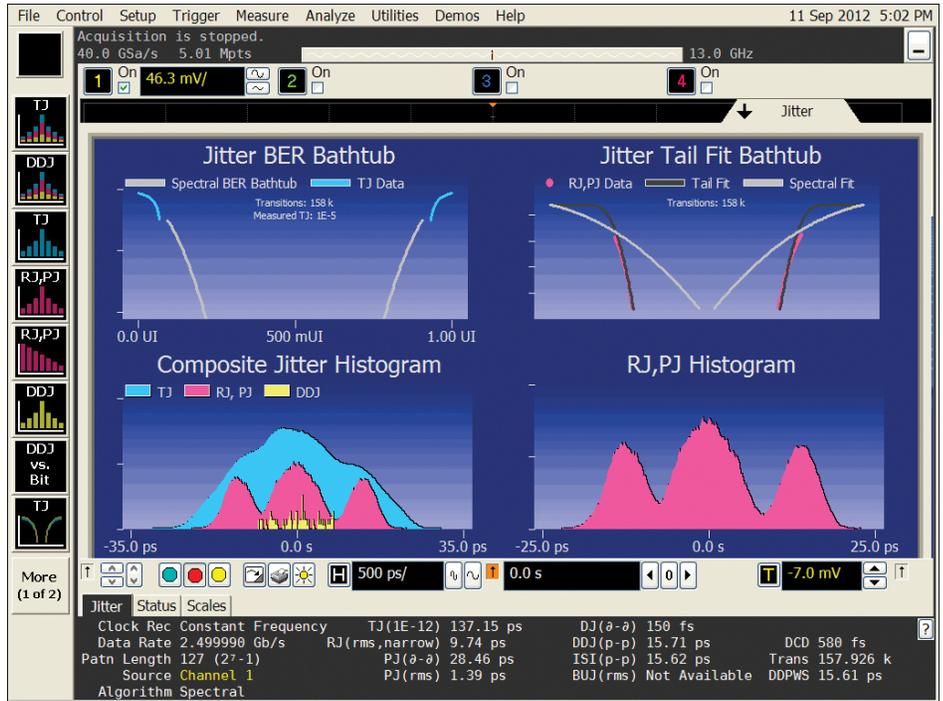


Figure 14. Jitter separation with artificially extreme crosstalk using spectral algorithm for RJ extraction. Notice the discontinuity in the BER bathtub.

The solution

EZJIT Complete provides two distinct algorithms for RJ extraction to ensure you achieve accurate measurements under all signal conditions.

The Tail Fit algorithm accurately extracts RJ, even in extreme ABUJ/crosstalk environments, by fitting directly to the tail of the RJ,PJ histogram.

Figures 14 and 15 contrast the two algorithms in a contrived jitter measurement with extreme crosstalk. You can see the tail fit algorithm in Figure 5 provides a much better fit to the BER bathtub curve in the upper left and reports significantly lower RJ and TJ results.

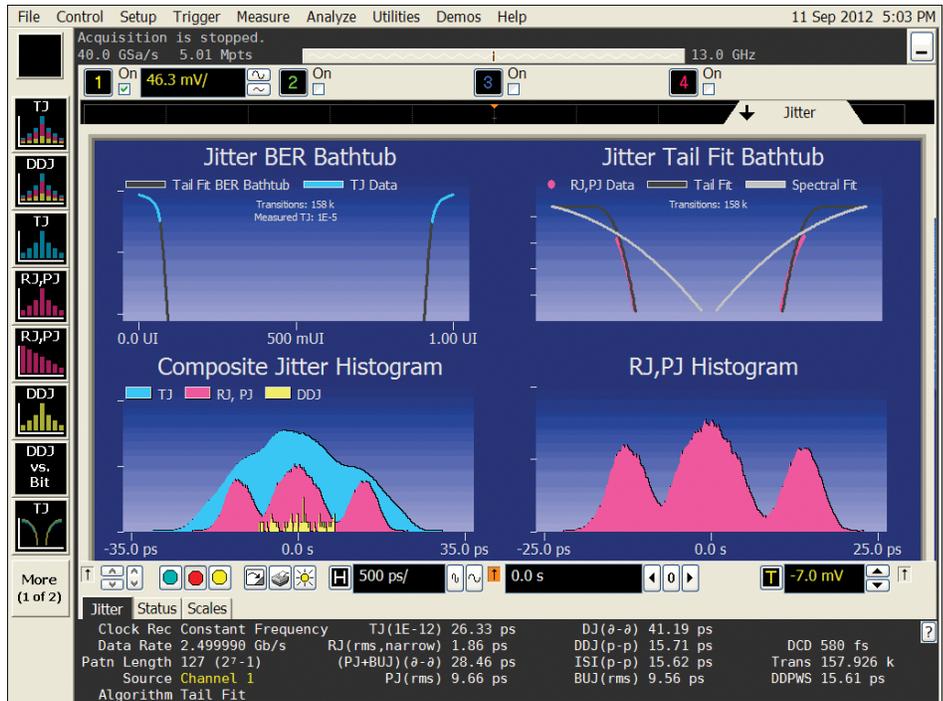


Figure 15. Jitter separation with artificially extreme crosstalk using tail fit algorithm for RJ extraction. Notice the good fit to the BER bathtub and dramatically lower RJ and TJ results.

Jitter Separation and Total Jitter Estimation at Low BER

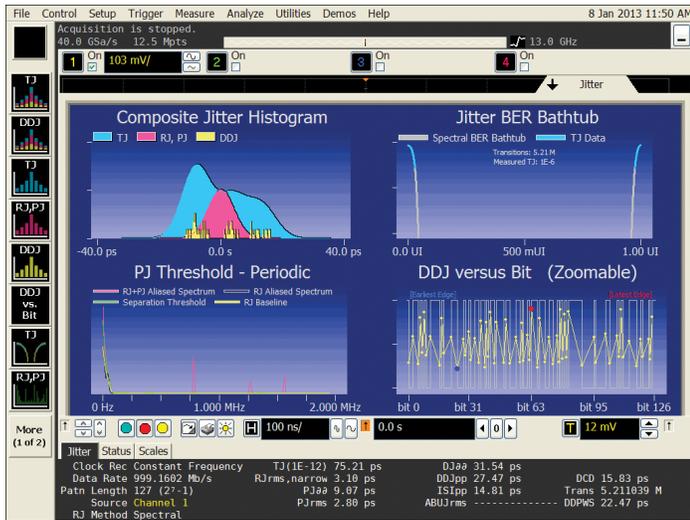


Figure 16.

4-in-1 jitter measurement results display allow for multiple views of jitter populations and distributions, data-dependent jitter versus bit in repetitive patterns, as well as the bathtub curve plot, which measures eye-opening vs. bit error rate.

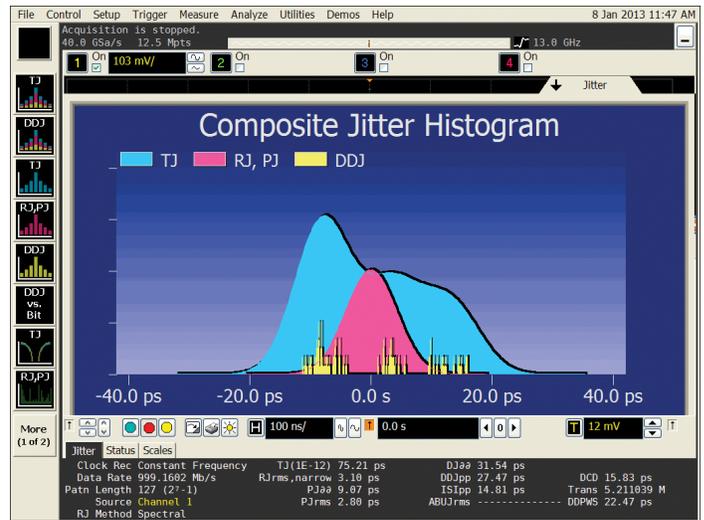


Figure 17.

Composite histogram displays relative contributions of data-dependent jitter, total jitter as well as random and periodic jitter. Total jitter is a convolution of the data-dependent jitter probability density function (PDF) and the random/periodic jitter PDF.

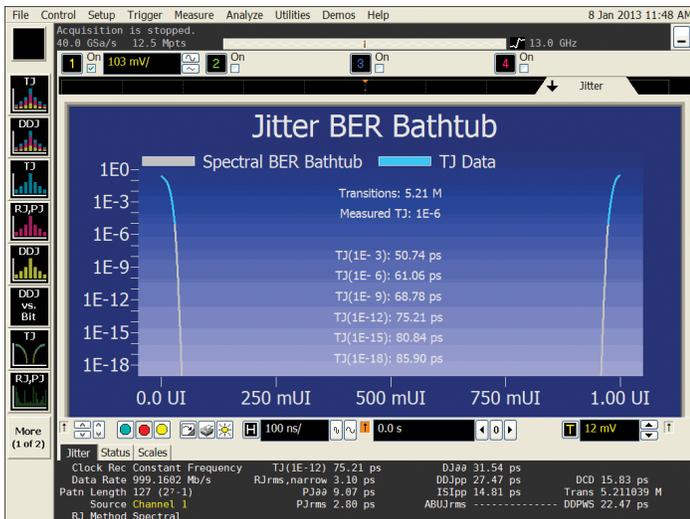


Figure 18.

Simplified display leverages existing measurement results tabs and measurement toolbars, integrating the EZJIT Plus measurement capability into the Infiniium display window. When the RJ/DJ graphical display window is minimized to view the voltage vs. time waveform under test, the jitter separation results are still visible in the jitter measurement results tab.

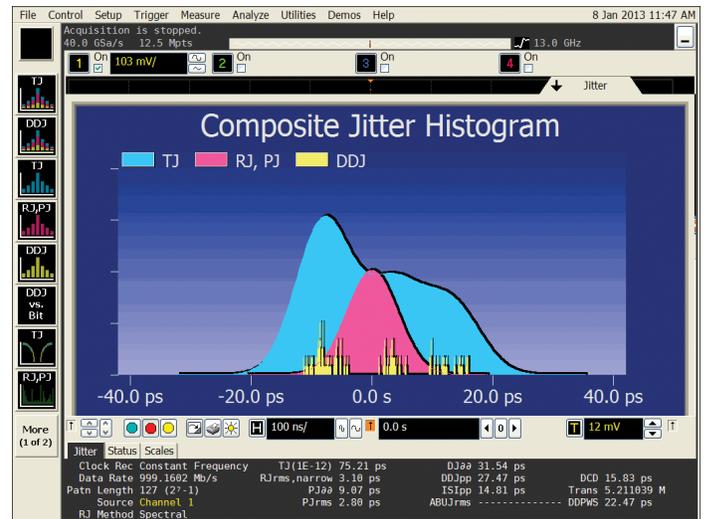


Figure 19.

A step-by-step wizard simplifies complex jitter measurement setups and allows for complete user control over important parameters such as the measurement threshold voltage and clock recovery method.

EZJIT: Essential Jitter Analysis Tools

Included with EZJIT Plus

Jitter analysis made easy

A wizard in the EZJIT jitter analysis software helps you quickly set up the Infiniium oscilloscopes and begin taking measurements. With time-correlated jitter trend and signal waveform displays, the relationships between jitter and signal conditions are more clearly visible. Intuitive displays and clear labeling of information make it easy to comprehend measurement results.

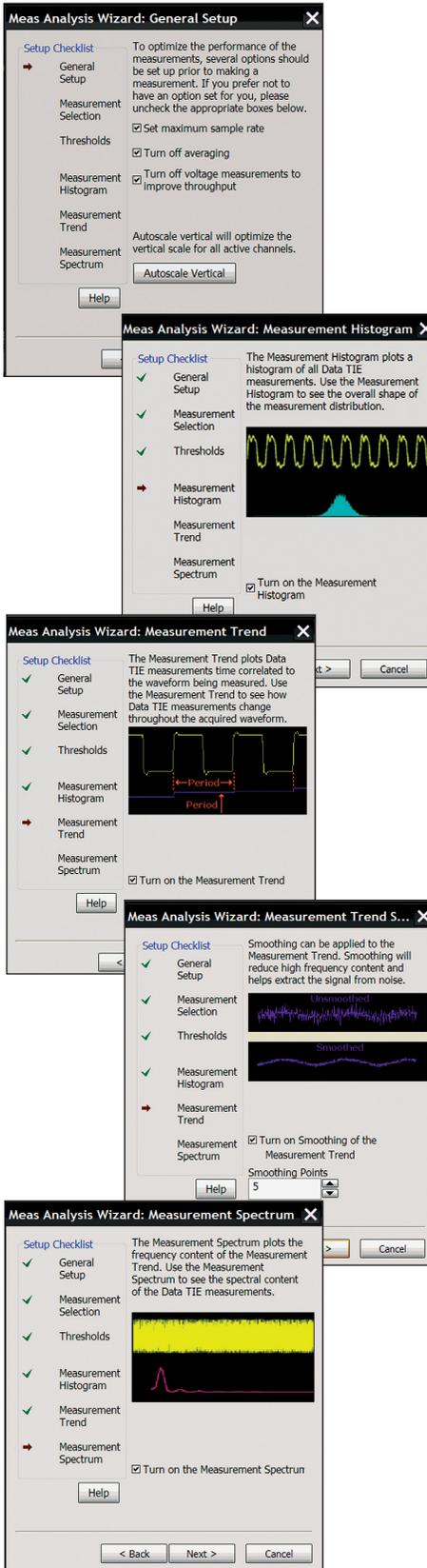


Figure 20. The setup wizard prompts you to select measurement thresholds, histogram, jitter trend, and/or spectrum displays.

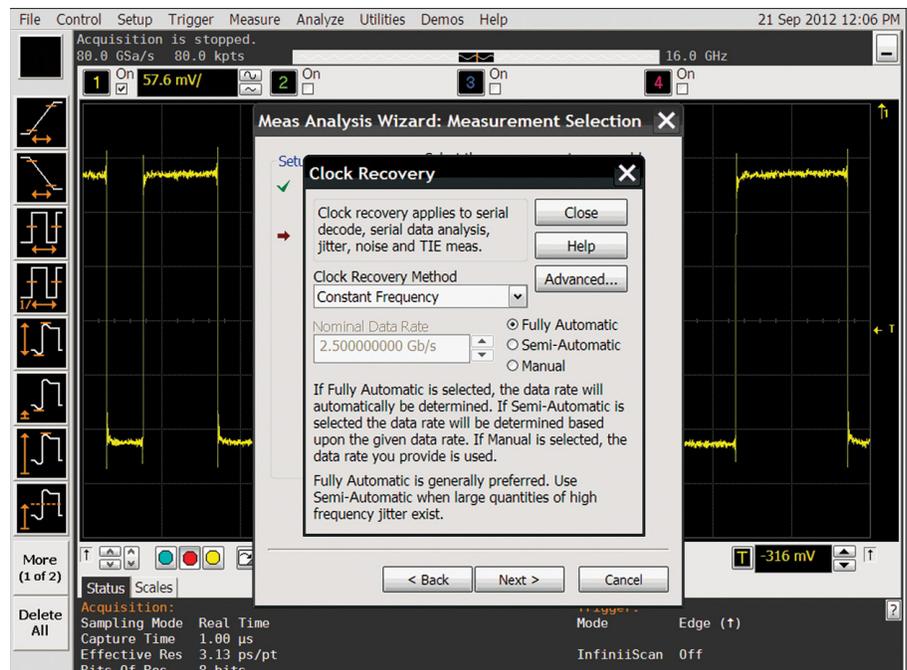


Figure 21. The EZJIT wizard simplifies jitter measurement setup, such as advanced clock recovery, shown here.

EZJIT: Essential Jitter Analysis Tools (Continued)

Extensive parametric analysis

EZJIT jitter analysis software can analyze the time variability of any of the following fundamental parametric measurements:

Single-source

- Period
- Frequency
- Positive pulse width
- Negative pulse width
- Duty cycle
- Rise time
- Fall time

Dual-source

- Setup time
- Hold time
- Phase

Clock

- Time-interval error (TIE)
- N - Period jitter
- Period to period jitter
- Pos width to Pos width jitter
- Neg width to Neg width jitter
- Cycle-to-cycle duty cycle

Data

- Time interval error (TIE)
- Data rate
- Unit interval
- n - UI jitter
- UI - UI jitter
- Clock recovery rate

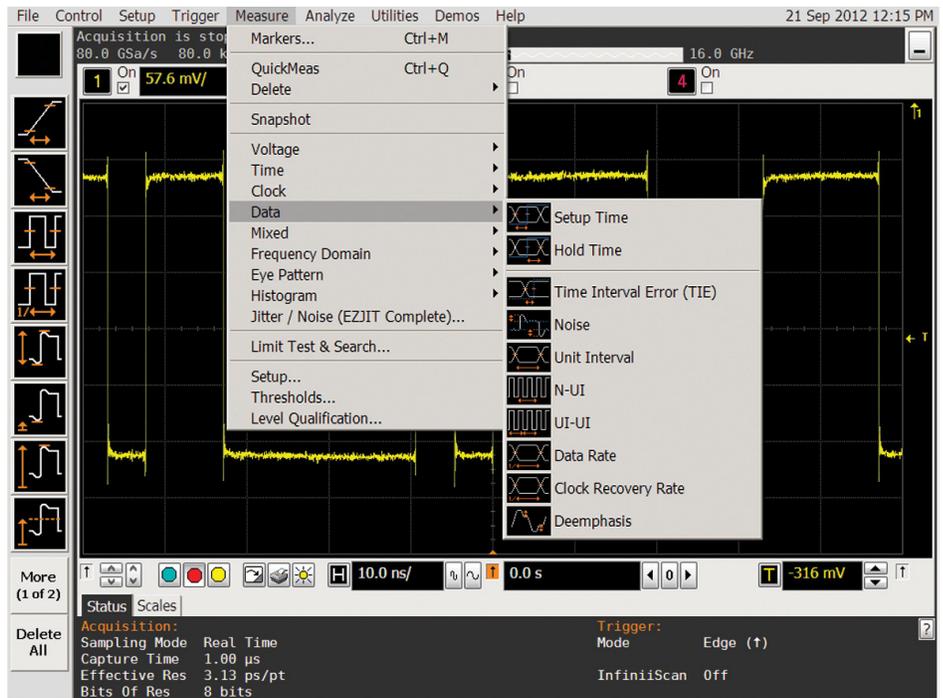


Figure 22. Extensive parametric analysis provides insight into data jitter components.

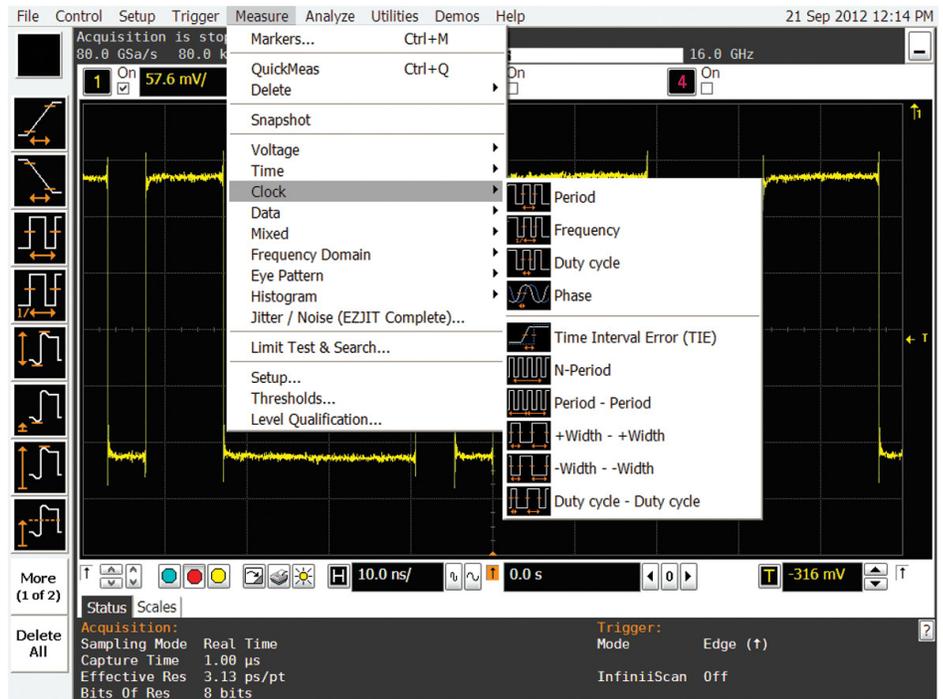


Figure 23. Clock jitter measurements provides insight into clock jitter components.

EZJIT: Essential Jitter Analysis Tools *(Continued)*

Real-time trend, histogram, and spectrum displays

Measurement data can be viewed as a trend display (Figure 24), showing a time plot of the measurement time-correlated with the signal waveform data. This makes it easy to understand relationships between jitter and signal conditions, such as intersymbol interference (ISI).



Figure 24. A trend display, showing a time plot of the measurement time-correlated with the signal waveform data, makes it easy to understand relationships between jitter and signal conditions.

The histogram display (Figure 25) plots the relative occurrence of values for the measured parameter. The histogram provides insight into the statistical nature of the jitter.

For example, the histogram shown in Figure 25 appears as two gaussian distributions. The peak-to-peak jitter between the gaussians indicates significant deterministic jitter in the signal, while the gaussians show the spread of random jitter.

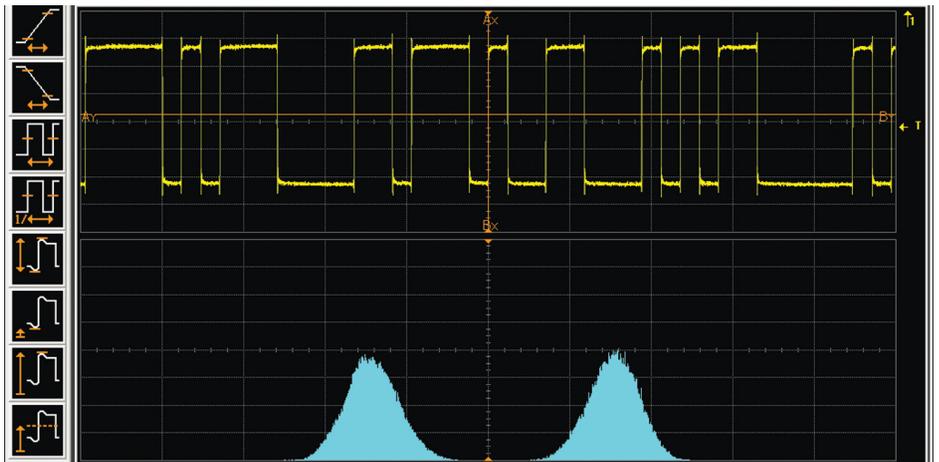


Figure 25. A histogram display plots the relative occurrence of values for the measured parameter, providing insight into the statistical nature of the jitter.

The spectrum display (Figure 26) shows the spectral content of the jitter. The spectrum display can be useful for identifying sources of jitter by their frequency components. For example, if you suspect a switching power supply with a switching frequency of 33-KHz is injecting jitter, you can test your theory by examining the jitter spectrum for a peak at 33-KHz.

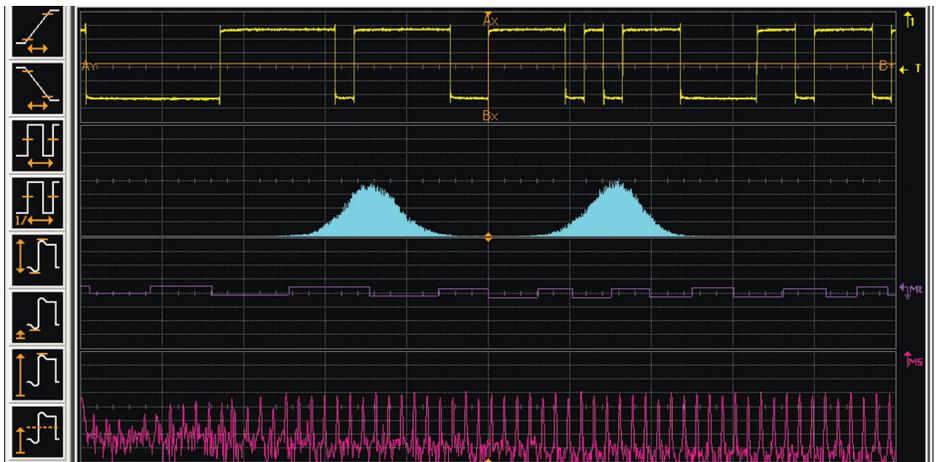


Figure 26. A spectrum display shows the spectral content of the jitter, useful for identifying sources of jitter by their frequency components.

EZJIT: Essential Jitter Analysis Tools *(Continued)*

Flexible clock recovery

You can choose constant-frequency or phase-locked loop (PLL) clock recovery as well as use an explicit clock on another input channel to time the data transition. With PLL clock recovery, the data rate and loop bandwidth are adjustable.

Many standards allow the use of spread-spectrum clocking to avoid concentrating EMI and RFI at specific frequencies. Spread-spectrum clocking is simply FM modulation of the clock frequency, usually at some frequency well below the clock frequency. The bandwidth of the PLL in the receiver hardware allows it to track the slow change in the clock frequency while allowing faster changes to be measured.



Figure 27. You can choose constant-frequency or phase-locked loop (PLL) clock recovery. With PLL clock recovery, the data rate, loop bandwidth and damping factor are adjustable.

EZJIT: Essential Jitter Analysis Tools *(Continued)*

Deep memory captures low-frequency jitter

Deep memory is especially valuable for jitter analysis. The optional 2 Gpts memory on the Keysight Technologies, Inc. V-Series and Z-Series is helpful in measuring low frequency jitter. At a sample rate of 80 GSa/s and incoming data rate of 2.5 Gb/s, 2 Gpts allows you to capture jitter frequency components down to 40 Hz. Comparably in the 9000, S-Series, and 90000A Series, the 40 GSa/s sample rate and optional 1 Gpts memory allows you to capture jitter frequency components as low as 40 Hz.

In some cases, measuring low-frequency jitter is not required; for example, the clock recovery PLL in most serial data receivers can reject jitter very effectively at moderately low frequencies. But sometimes an event occurring at a low repetition rate can cause bursts of jitter or noise with higher frequencies that the PLL cannot reject.

An example is shown in Figure 28. The upper yellow trace is a serial data signal. The middle green trace shows an uncorrelated aggressor signal that is causing short-term bursts of jitter in the data signal. The lower purple trace, showing a jitter trend signal derived from the serial data signal, plots the timing of each edge in the data stream compared to the "ideal" recovered clock. You can see a burst of timing errors that coincides with each transition in the middle green signal.

Further jitter analysis support

For additional jitter analysis features, including Rj/Dj separation, bathtub curve generation, and ABUJ extraction, Keysight offers the N5400A EZJIT Plus jitter analysis software.

For even deeper insight, apply the same deep analysis and component separation to the vertical noise affecting your signal using Keysight's N8823A EZJIT Complete software.

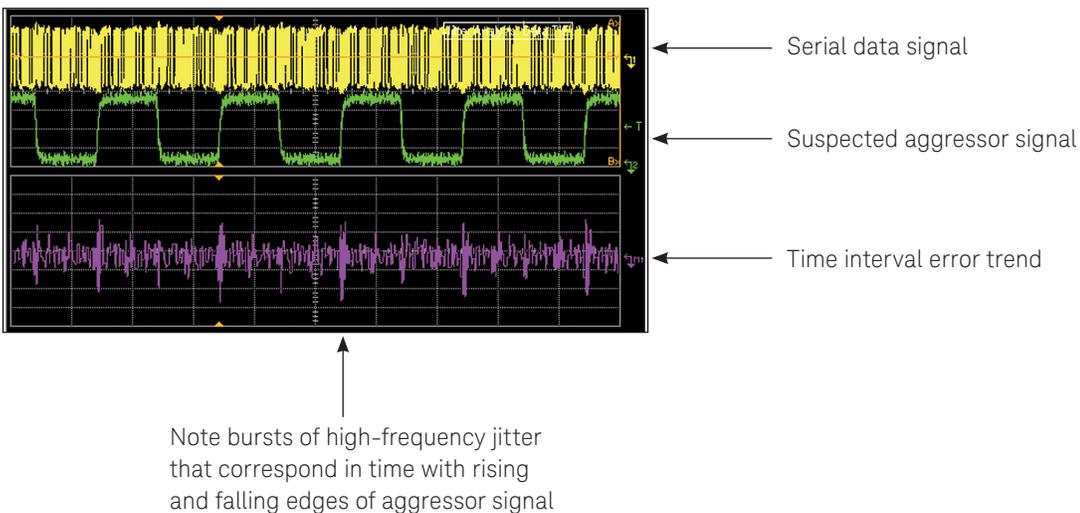


Figure 28. The clock recovery PLL in most serial data receivers can reject jitter at low frequencies. However, sometimes events occurring at low frequencies (middle green trace) can cause bursts of jitter that contain higher frequencies that the PLL cannot reject (lower purple trace).

Oscilloscope Compatibility

Oscilloscopes	Software revision
Z-Series	5.0 or higher
V-Series	5.0 or higher
S-Series	5.0 or higher
90000 Series	2.1 or higher
9000 Series	2.0 or higher

Ordering Information

To purchase the EZJIT software with a new or existing Infiniium Series oscilloscope, order the following options.

Application	License type		Infiniium V-Series/Z-Series	Infiniium S- Series	Infiniium 90000 Series	Infiniium 9000 Series
EZJIT Complete	Fixed	Factory-installed	N8823A-1FP	N8823B-1FP	DSO90000-070	DSO9000-070 and MSO9000-070
		User-installed	N8823A-1FP	N8823B-1FP	N8823A-1NL	N8823B-1NL
	Floating	Transportable	N8823A-1TP	N8823B-1TP	N8823A-1TP	N8823B-1TP
		Server-based	N5435A-067	N5435A-067	N5435A-067	N5435A-067
EZJIT Plus	Fixed	Factory-installed	N5400A-1FP	N5400B-1FP	DSO90000A-004	DSO9000A-004 and MSO9000A-004
		User-installed	N5400A-1FP	N5400B-1FP	N5400A-1NL	N5400B-1NL
	Floating	Transportable	N5400A-1TP	N5400B-1TP	N5400A-1TP	N5400B-1TP
		Server-based	N5435A-001	N5435A-001	N5435A-001	N5435A-001
EZJIT	Fixed	Factory-installed	E2681A-1FP	E2681B-1FP	DSO90000A-002	DSO9000A-002 and MSO9000A-002
		User-installed	E2681A-1FP	E2681B-1FP	E2681A-1NL	E2681B-1NL
	Floating	Transportable	E2681A-1TP	E2681B-1TP	E2681A-1TP	E2681B-1TP
		Server-based	N5435A-002	N5435A-002	N5435A-002	N5435A-002

Other Measurement Software for High Speed Digital Data Analysis

Model number	Title	Description
Infiniium real-time oscilloscopes		
N5461A	Equalization	Select from CTLE, FFE and DFE equalization types and various clock topologies to understand what equalization will do to a signal, or to model voltage eye internal to receiver device.
N2809A & N2806A	Precision Probe Software and Hardware Kit	Measure and remove effects of cable and switch paths in front of the oscilloscope, measure and AC calibrate probes for greatest accuracy and bandwidth.
N5465A	InfiniiSim Waveform Transformation Toolset	Creates transfer functions for implementing de-embedding of fixtures and cables, embedding, general simulation, removing probe loading and changing observation point of measurement.
E2688A	Serial Data Analysis	Create eye diagrams of total captured waveform or of particular filtered portions of it (i.e. bit sequence dependence). Includes standard masks and 8b/10b protocol analysis.
Sampling oscilloscopes: 86100D series digital communication analyzer		
86100D-300	Advanced Amplitude Analysis	Infiniium DCA software option that performs the highest accuracy amplitude analysis available.
86100D-200	Advanced Jitter Analysis	Jitter decomposition using dual dirac technique. Predict total jitter to low BERs.
86100D-201	Advanced Jitter Analysis	Equalize signals using software CTLE and FFE/LFE models.
86100D-202	Enhanced Impedance and S-parameter SW	Single-ended and differential S-parameter measurements.
86100D-300	Advanced Amplitude Analysis	Infiniium DCA software option that performs the highest accuracy amplitude analysis available.
86100DU-401	Advanced Eye Analysis	Jitter and amplitude/noise analysis on long patterns such as PRBS31. Eye contour and eye/mask testing.
86100D-SIM	InfiniiSim-DCA	Creates transfer functions used to de-embed/embed fixtures and cables, general simulation, removing probe loading and changing observation point of measurement.

Related Literature

Publication title	Publication number
<i>Infiniium 90000 Series Oscilloscopes - Data Sheet</i>	5989-7819EN
<i>Infiniium DCA-X 86100D Wide-Bandwidth Oscilloscope Mainframe and Modules - Brochure</i>	5990-5822EN
<i>Infiniium Z-Series Oscilloscopes - Data Sheet</i>	5991-3868EN
<i>Infiniium S-Series High-Definition Oscilloscopes - Data Sheet</i>	5991-3904EN
<i>Infiniium V-Series Oscilloscopes - Data Sheet</i>	5992-0425EN

For copies of this literature, contact your Keysight representative or visit www.keysight.com/find/scope-apps.



www.axistandard.org

AdvancedTCA® Extensions for Instrumentation and Test (AXIe) is an open standard that extends the AdvancedTCA for general purpose and semiconductor test. Keysight is a founding member of the AXIe consortium. ATCA®, AdvancedTCA®, and the ATCA logo are registered US trademarks of the PCI Industrial Computer Manufacturers Group.



www.lxistandard.org

LAN eXtensions for Instruments puts the power of Ethernet and the Web inside your test systems. Keysight is a founding member of the LXI consortium.



www.pxisa.org

PCI eXtensions for Instrumentation (PXI) modular instrumentation delivers a rugged, PC-based high-performance measurement and automation system.

Evolving Since 1939

Our unique combination of hardware, software, services, and people can help you reach your next breakthrough. We are unlocking the future of technology.

From Hewlett-Packard to Agilent to Keysight.



For more information on Keysight Technologies' products, applications or services, please contact your local Keysight office. The complete list is available at: www.keysight.com/find/contactus

Americas

Canada	(877) 894 4414
Brazil	55 11 3351 7010
Mexico	001 800 254 2440
United States	(800) 829 4444

Asia Pacific

Australia	1 800 629 485
China	800 810 0189
Hong Kong	800 938 693
India	1 800 11 2626
Japan	0120 (421) 345
Korea	080 769 0800
Malaysia	1 800 888 848
Singapore	1 800 375 8100
Taiwan	0800 047 866
Other AP Countries	(65) 6375 8100

Europe & Middle East

Austria	0800 001122
Belgium	0800 58580
Finland	0800 523252
France	0805 980333
Germany	0800 6270999
Ireland	1800 832700
Israel	1 809 343051
Italy	800 599100
Luxembourg	+32 800 58580
Netherlands	0800 0233200
Russia	8800 5009286
Spain	800 000154
Sweden	0200 882255
Switzerland	0800 805353
	Opt. 1 (DE)
	Opt. 2 (FR)
	Opt. 3 (IT)
United Kingdom	0800 0260637

For other unlisted countries: www.keysight.com/find/contactus (BP-9-7-17)

DEKRA Certified
ISO 9001 Quality Management System

www.keysight.com/go/quality
Keysight Technologies, Inc.
DEKRA Certified ISO 9001:2015
Quality Management System

myKeysight

myKeysight

www.keysight.com/find/mykeysight

A personalized view into the information most relevant to you.

www.keysight.com/find/emt_product_registration

Register your products to get up-to-date product information and find warranty information.

KEYSIGHT SERVICES

Accelerate Technology Adoption.
Lower costs.

Keysight Services

www.keysight.com/find/service

Keysight Services can help from acquisition to renewal across your instrument's lifecycle. Our comprehensive service offerings—one-stop calibration, repair, asset management, technology refresh, consulting, training and more—helps you improve product quality and lower costs.



Keysight Assurance Plans

www.keysight.com/find/AssurancePlans

Up to ten years of protection and no budgetary surprises to ensure your instruments are operating to specification, so you can rely on accurate measurements.

Keysight Channel Partners

www.keysight.com/find/channelpartners

Get the best of both worlds: Keysight's measurement expertise and product breadth, combined with channel partner convenience.

www.keysight.com/find/EZJITComplete



Unlocking Measurement Insights

This information is subject to change without notice.
© Keysight Technologies, 2017
Published in USA, December 1, 2017
5991-0523EN
www.keysight.com